1 [33131 1814 88431 88411 8841 1888 1814 1884 1884	Sear	ch Notes

Application/Control No.	Applicant(s)/Patent under Reexamination KURODA ET AL.	
10/541,320		
Examiner	Art Unit	

Helen C. Kwok

2856

	SEARCHED			
Class	Subclass	Date	Examiner	
73	504.04	7/31/2007	нк	
73	504.02	7/31/2007	нк	
73	504.12	7/31/2007	нк	
73	504.16	7/31/2007	нк	
73	504.15	7/31/2007	нк	
73 .	1.37	7/31/2007	нк	
73	1.38	7/31/2007	нк	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
		,	
	1		

(INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
			-
	ļ		
		1	
	l		
			•
	- 1		
· · · · · · · · · · · · · · · · · · ·			
			: